

General Rules and Requirements

1.	All information provided should be true.								
2.	Sample submission procedure.								
	a. Complete the Sample Submission Form including a valid research vote number.								
	b. For sample submission via walk-in : Submit the completed Sample Submission Form an Sample Acceptance Counter								
	c.	For sample submission via mail : Submit the completed Sample Submission Form and the samples. Samples must be packaged in a suitable container for courier delivery. The parcel should be addressed to the person in charge of the instrument, as it will be received directly by them.							
3.	Fast lane Service : A priority testing service that provides results within 3 to 7 working days instead of the usual 14 working days. It is offered based on availability with an additional 50% charge from the normal price. Customers must contact the person in charge for this service.								
4.	For sample criteria and conditions, refer to UIRL Sample Submission Criteria in the PPMU website at ppmu.utm.my								
5.	PPMU has the right to cancel any analysis if the sample is suspected to have a high risk on the safety of the operator or can cause damage to the instrument during the analysis. The cost of damages will be borne by the customer. Posted samples will be received by laboratory personnel.								
6.	Only samples that are ready to be analyzed are accepted by the lab.								
7.	The remaining samples will be disposed of within a month after analysis is completed.								
8.	Quotation will be provided upon request.								
9.	Payment must be made within fourteen (14) working days after invoice is issued.								
10.	Analysis duration is within fourteen (14) working days after receiving the samples.								
11.	The laboratory will provide test results after the payment proof presented to the laboratory personnel.								
12.	All inquiries regarding FIB FESEM-EDX should be forwarded to the Assistant Engineer (Mr. Al Azhari bin Amir Hatib, email: alazhari@utm.my) / Assistant Engineer (Mr. Ahmad Safuan Borhan, email: a.safuan@utm.my) or visit our website at ppmu.utm.my tel: 07-561 0268.								
* 11 00	and much	be submitted							

*All pages must be submitted

		Form Num.	UIRL/F/03							
		Version	2/2025							
	PUSAT PENGURUSAN MAKMAL	Effective Date	15/05/2025							
UNIVERSITI TEKNOLOGI MALAYSIA	UNIVERSITI (PPMU)	Equipment	FIB FESEM-EDX							
	, , , , , , , , , , , , , , , , , , ,	Sample Serial No.	UIRL/							
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DUAL BEAM MICROSCOPE (FIB-SEM) LABORATORY										
SAMPLE SUBMISSION FORM										

Application Details :

1. APPLICANT'S PERSONAL PARTICULARS											
Name of Applicant											
Status of Applicant		Undergraduates		Master		PhD	Researcher				
Student Matric No.											
Faculty/ Department											
Hand Phone No.											
Email											
2. SUPERVISOR DETAILS											
Name of Supervisor											
Staff ID No.											
Faculty/Department											
Hand Phone No.											
Email											
Signature & Official Stamp	*A digital signature is not recommended. Any matters raised in the future are beyond our responsibilities										
	I have read and agreed to the General Rules and Requirements										
3. PAYMENT			_			-					
Method of Payment		UTM PayHub System		Log card		Invoice					
Mode of Service	Normal Fast Lane										
	Research Vot No.										
Payment using Invoice	(e.g.: Q.J091600.24C3.01D32)										
	Balance of V29000										
4. SAMPLE & ANALYSIS INFORMATION	1										
Name of Sample											
Total Number of Sample/s						· · · · · · · · · · · · · · · · · · ·					
Type of Sample	Powder Solid Invoice										
	Note	Samples must be dried a	and ho								
Sample Properties		Тохіс		Carcinogenic		Others :		-			
Sample ID/Labels											
Test Required	FIB			In h base Disp Instr		based on Manua Dispersive X-Ray Instruments) and	EDX In house-method, UIRL/STP/06 based on Manual for Energy Dispersive X-Ray (Oxford Instruments) and Manuals for Scanning Electron Microscope				
Type of FIB Testing		Milling Deposition Preparation of 1		Preparation of TE	EM Lamella						
Type of EDX Testing		Point ID		Linescan Mapping							
EDX Result Information	Atomic Weight										
Expected Elements / Chemical Formula											
Description / Notes (Eg: Image magnification required etc.)											